



U.S. PATENT DOCUMENTS

Examiner Initials*	Cite No. ¹	Document Number Number Kind Code? (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
MW	AA	US-D507,405	7-19-2005	Kim et al.	
MW	AB	US-5,440,784	8-15-1995	Hull et al.	
MW	AC	US-5,265,307	11-30-1993	Hull et al.	
MW	AD	US-6,301,746	10-16-2001	Myers et al.	
	AE	US-			
	AF	US-			
	AG	US-			
	AH	US-			
	AI	US-			
	AJ	US-			
	AK	US-			
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FOREIGN PATENT DOCUMENTS

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		Country Code ³	Number ⁴	Kind Code ⁶ (if known)				
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NON PATENT LITERATURE DOCUMENTS

Examiner Signature	/Mark Williams/ (05/01/2006)	Date Considered	
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¹ Applicant's unique citation designation number (optional). ² Applicant is to place a check mark here if English language Translation is attached.